


<b>Search Notes</b>  	<b>Application/Control No.</b>  10580545	<b>Applicant(s)/Patent Under Reexamination</b>  NAKANE, KATSUAKI
	<b>Examiner</b>  JACK YIP	<b>Art Unit</b>  3715

SEARCHED			
Class	Subclass	Date	Examiner
434	322, 323, 353, 350	5/21/2009	JY

SEARCH NOTES		
Search Notes	Date	Examiner
East Search	5/21/2009	JY
eDan Inventor Search	5/21/2009	JY

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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